

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/836,561	BANDMAN ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Sheela J Huff	1642	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5872234	02-1999	Bandman et al	
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	Q					
	R					
	S					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Skolnick et al TIBTECH vol. 18 p. 34 (1/2000)
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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